Memory FRAM

64 K (8 K \times 8) Bit SPI

MB85RS64

■ DESCRIPTION

MB85RS64 is a FRAM (Ferroelectric Random Access Memory) chip in a configuration of $8,192 \text{ words} \times 8 \text{ bits}$, using the ferroelectric process and silicon gate CMOS process technologies for forming the nonvolatile memory cells.

MB85RS64 adopts the Serial Peripheral Interface (SPI).

The MB85RS64 is able to retain data without using a back-up battery, as is needed for SRAM.

The memory cells used in the MB85RS64 can be used for 10¹² read/write operations, which is a significant improvement over the number of read and write operations supported by Flash memory and E²PROM. MB85RS64 does not take long time to write data like Flash memories or E²PROM, and MB85RS64 takes no wait time.

■ FEATURES

• Bit configuration : $8,192 \text{ words} \times 8 \text{ bits}$

• Serial Peripheral Interface : SPI (Serial Peripheral Interface)

Correspondent to SPI mode 0 (0, 0) and mode 3 (1, 1)

Operating frequency
 High endurance
 20 MHz (Max)
 10¹² times / byte

Data retention
 : 10 years (+85 °C), 95 years (+55 °C), over 200 years (+35 °C)

Operating power supply voltage : 2.7 V to 3.6 V

Low power consumption : Operating power supply current 1.5 mA (Typ@20 MHz)

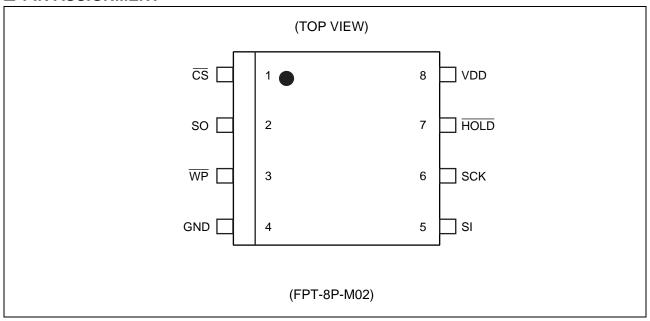
Standby current 5 µA (Typ)

Operation ambient temperature range : − 40 °C to +85 °C

Package : 8-pin plastic SOP (FPT-8P-M02) RoHS compliant



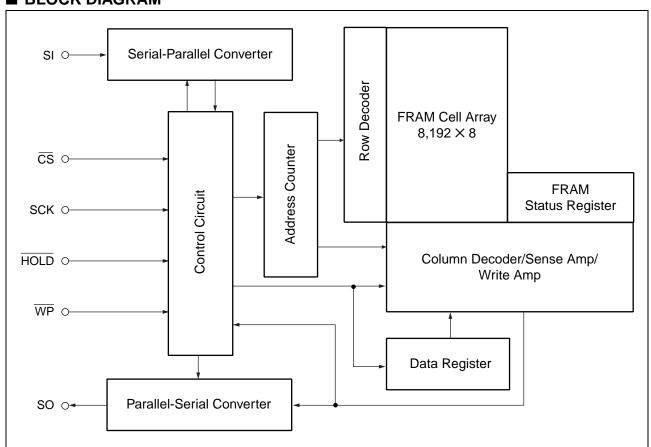
■ PIN ASSIGNMENT



■ PIN FUNCTIONAL DESCRIPTIONS

Pin No.	Pin Name	Functional description
1	CS	Chip Select pin This is an input pin to make chip select. When \overline{CS} is the "H" level, device is in deselect (standby) status and SO becomes High-Z. Inputs from other pins are ignored at this time. When \overline{CS} is the "L" level, device is in select (active) status. \overline{CS} has to be the "L" level before inputting op-code. The Chip Select pin is pulled up internally to the VDD pin.
3	WP	Write Protect pin This is a pin to control writing to a status register. The writing of status register (see "■ STATUS REGISTER") is protected in related with WP and WPEN. See "■WRITING PROTECT" for detail.
7	HOLD	Hold pin This pin is used to interrupt serial input/output without making chip deselect. When HOLD is the "L" level, hold operation is activated, SO becomes High-Z, and SCK and SI become don't care. While the hold operation, CS shall be retained the "L" level.
6	SCK	Serial Clock pin This is a clock input pin to input/output serial data. SI is loaded synchronously to a rising edge, SO is output synchronously to a falling edge.
5	SI	Serial Data Input pin This is an input pin of serial data. This inputs op-code, address, and writing data.
2	SO	Serial Data Output pin This is an output pin of serial data. Reading data of FRAM memory cell array and status register are output. This is High-Z during standby.
8	VDD	Supply Voltage pin
4	GND	Ground pin

■ BLOCK DIAGRAM

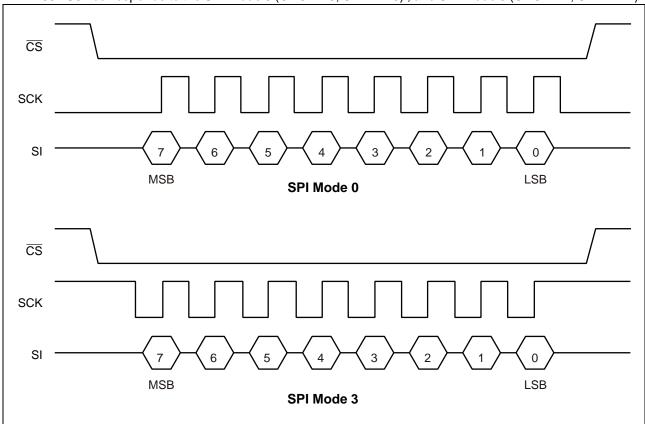


MB85RS64

■ SPI MODE

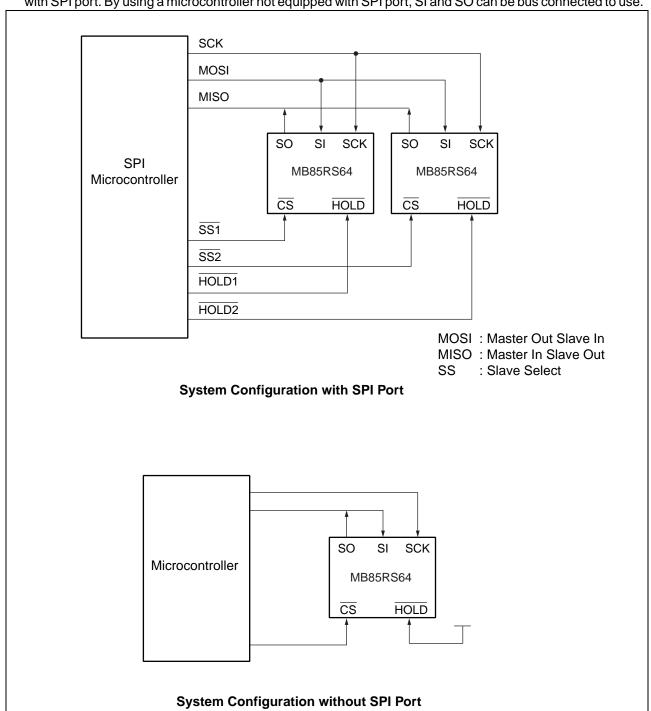
4

MB85RS64 corresponds to the SPI mode 0 (CPOL = 0, CPHA = 0), and SPI mode 3 (CPOL = 1, CPHA = 1).



■ SERIAL PERIPHERAL INTERFACE (SPI)

MB85RS64 works as a slave of SPI. More than 2 devices can be connected by using microcontroller equipped with SPI port. By using a microcontroller not equipped with SPI port, SI and SO can be bus connected to use.



■ STATUS REGISTER

Bit No.	Bit Name	Function
7	WPEN	Status Register Write Protect This is a bit composed of nonvolatile memories (FRAM). WPEN protects writing to a status register (see "■ WRITING PROTECT") relating with WP input. Writing with the WRSR command and reading with the RDSR command are possible.
6 to 4	_	Not Used Bits These are bits composed of nonvolatile memories, writing with the WRSR command is possible, and "000" is written before shipment. These bits are not used but they are read with the RDSR command.
3	BP1	Block Protect This is a bit composed of nonvolatile memory. This defines size of write
2	BP0	protect block for the WRITE command (see "■ BLOCK PROTECT"). Writing with the WRSR command and reading with the RDSR command are possible.
1	WEL	Write Enable Latch This indicates FRAM Array and status register are writable. The WREN command is for setting, and the WRDI command is for resetting. With the RDSR command, reading is possible but writing is not possible with the WRSR command. WEL is reset after the following operations. After power ON. After WRDI command recognition. At the rising edge of CS after WRSR command recognition. At the rising edge of CS after WRITE command recognition.
0	0	This is a bit fixed to "0".

■ OP-CODE

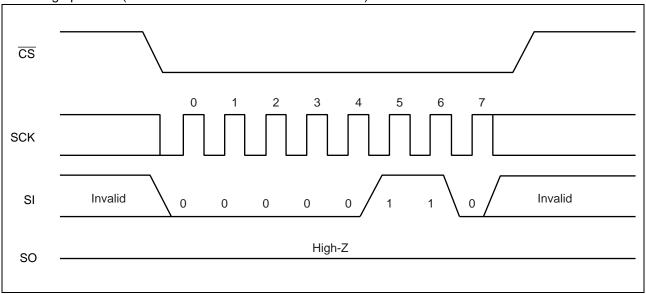
MB85RS64 accepts 6 kinds of command specified in op-code. Op-code is a code composed of 8 bits shown in the table below. Do not input invalid codes other than those codes. If $\overline{\text{CS}}$ is risen while inputting op-code, the command are not performed.

Name	Description	Op-code
WREN	Set Write Enable Latch	0000 0110в
WRDI	Reset Write Enable Latch	0000 0100в
RDSR	Read Status Register	0000 0101в
WRSR	Write Status Register	0000 0001в
READ	Read Memory Code	0000 0011в
WRITE	Write Memory Code	0000 0010в

■ COMMAND

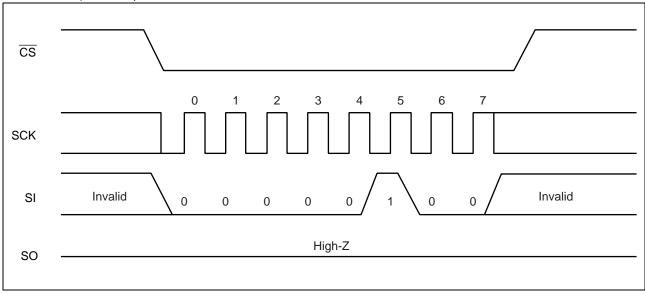
• WREN

The WREN command sets WEL (Write Enable Latch) . WEL shall be set with the WREN command before writing operation (WRSR command and WRITE command) .



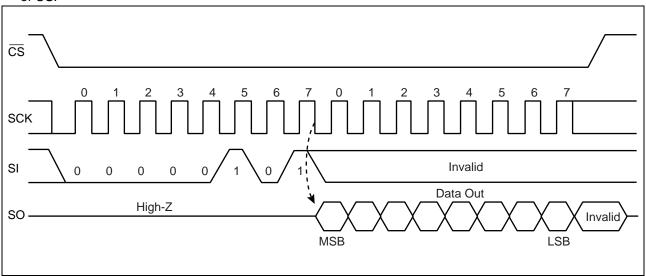
• WRDI

The WRDI command resets WEL (Write Enable Latch) . Writing operation (WRITE command and WRSR command) are not performed when WEL is reset.



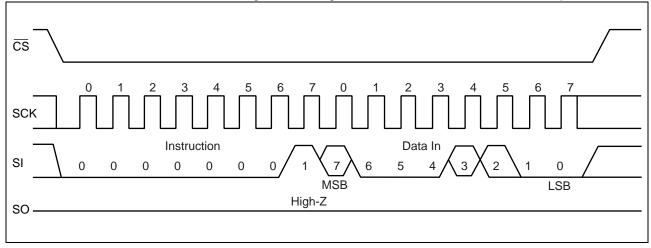
• RDSR

The RDSR command reads status register data. After op-code of RDSR is input to SI, 8-cycle clock is input to SCK. The SI value is invalid during this time. SO is output synchronously to a falling edge of SCK. In the RDSR command, repeated reading of status register is enabled by sending SCK continuously before rising of $\overline{\text{CS}}$.



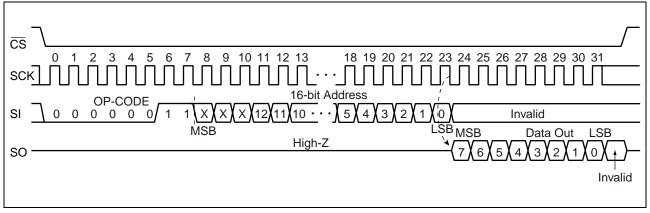
WRSR

The WRSR command writes data to the nonvolatile memory bit of status register. After performing WRSR op-code to a SI pin, 8 bits writing data is input. WEL (Write Enable Latch) is not able to be written with WRSR command. A SI value correspondent to bit 1 is ignored. Bit 0 of the status register is fixed to "0" and cannot be written. The SI value corresponding to bit 0 is ignored. The $\overline{\text{WP}}$ signal level shall be fixed before performing the WRSR command, and do not change the $\overline{\text{WP}}$ signal level until the end of command sequence.



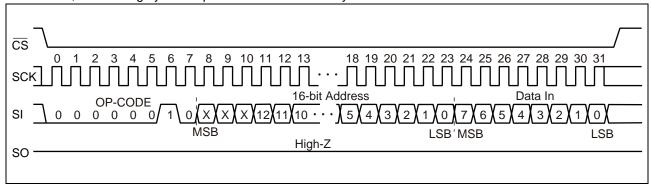
• READ

The READ command reads FRAM memory cell array data. Arbitrary 16 bits address and op-code of READ are input to SI. The 3-bit upper address bit is invalid. Then, 8-cycle clock is input to SCK. SO is output synchronously to the falling edge of SCK. While reading, the SI value is invalid. When $\overline{\text{CS}}$ is risen, the READ command is completed, but keeps on reading with automatic address increment which is enabled by continuously sending clocks to SCK in unit of 8 cycles before $\overline{\text{CS}}$ rising. When it reaches the most significant address, it rolls over to the starting address, and reading cycle keeps on infinitely.



• WRITE

The WRITE command writes data to FRAM memory cell array. WRITE op-code, arbitrary 16 bits of address and 8 bits of writing data are input to SI. The 3-bit upper address bit is invalid. When 8 bits of writing data is input, data is written to FRAM memory cell array. Risen \overline{CS} will terminate the WRITE command. However, if you continue sending the writing data for 8 bits each before \overline{CS} rising, it is possible to continue writing with automatic address increment. When it reaches the most significant address, it rolls over to the starting address, and writing cycle keeps on continued infinitely.



■ BLOCK PROTECT

Writing protect block for WRITE command is configured by the value of BP0 and BP1 in the status register.

BP1	BP0	Protected Block
0	0	None
0	1	1800н to 1FFFн (upper 1/4)
1	0	1000н to 1FFFн (upper 1/2)
1	1	0000н to 1FFFн (all)

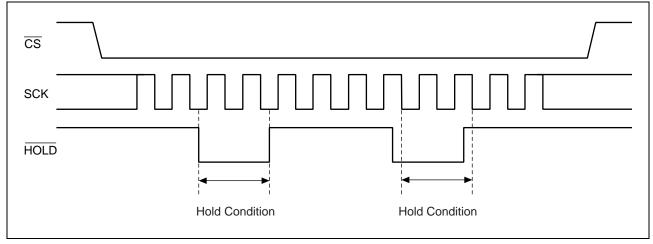
■ WRITING PROTECT

Writing operation of the WRITE command and the WRSR command are protected with the value of WEL, WPEN, WP as shown in the table.

WEL	WPEN	WP	Protected Blocks	Unprotected Blocks	Status Register
0	Х	Х	Protected	Protected	Protected
1	0	Х	Protected	Unprotected	Unprotected
1	1	0	Protected	Unprotected	Protected
1	1	1	Protected	Unprotected	Unprotected

■ HOLD OPERATION

Hold status is retained without aborting a command if $\overline{\text{HOLD}}$ is the "L" level while $\overline{\text{CS}}$ is the "L" level. The timing for starting and ending hold status depends on the SCK to be the "H" level or the "L" level when a $\overline{\text{HOLD}}$ pin input is transited to the hold condition as shown in the diagram below. In case the $\overline{\text{HOLD}}$ pin transited to "L" level when SCK is "L" level, return the $\overline{\text{HOLD}}$ pin to "H" level at SCK being "L" level. In the same manner, in case the $\overline{\text{HOLD}}$ pin transited to "L" level when SCK is "H" level, return the $\overline{\text{HOLD}}$ pin to "H" level at SCK being "H" level. Arbitrary command operation is interrupted in hold status, SCK and SI inputs become don't care. And, SO becomes High-Z while reading command (RDSR, READ). If $\overline{\text{CS}}$ is rising during hold status, a command is aborted. In case the command is aborted before its recognition, WEL holds the value before transition to hold status.



■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rat	Unit	
raiailletei	Symbol	Min	Max	Onit
Power supply voltage*	V_{DD}	- 0.5	+ 4.0	V
Input voltage*	Vin	- 0.5	V _{DD} + 0.5	V
Output voltage*	Vоит	- 0.5	V _{DD} + 0.5	V
Operation ambient temperature	TA	- 40	+ 85	°C
Storage temperature	Tstg	– 55	+ 125	°C

^{*:} These parameters are based on the condition that Vss is 0 V.

WARNING: Semiconductor devices may be permanently damaged by application of stress (including, without limitation, voltage, current or temperature) in excess of absolute maximum ratings.

Do not exceed any of these ratings.

■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol		Unit		
Farameter	Symbol	Min	Тур	Max	Offic
Power supply voltage*1	V _{DD}	2.7	3.3	3.6	V
Operation ambient temperature*2	TA	- 40	_	+ 85	°C

^{*1:} These parameters are based on the condition that Vss is 0 V.

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated under these conditions.

Any use of semiconductor devices will be under their recommended operating condition. Operation under any conditions other than these conditions may adversely affect reliability of device and could result in device failure.

No warranty is made with respect to any use, operating conditions or combinations not represented on this data sheet. If you are considering application under any conditions other than listed herein, please contact sales representatives beforehand.

^{*2:} Ambient temperature when only this device is working. Please consider it to be the almost same as the package surface temperature.

MB85RS64

■ ELECTRICAL CHARACTERISTICS

1. DC Characteristics

(within recommended operating conditions)

Daramatar	Symbol Condition				Linit		
Parameter	Symbol	Condition	Min	Тур	Max	Unit	
		0 ≤ CS < V _{DD}	_	_	200		
Input leakage current	 ⊔	CS = V _{DD}			10	μΑ	
	11-1	\overline{WP} , \overline{HOLD} , SCK, $SI = 0 \text{ V to V}_{DD}$	_	_	10	μΑ	
Output leakage current	I LO	SO = 0 V to V _{DD}	_	_	10	μΑ	
Operating power supply current	I DD	SCK = 10 MHz		0.75	_	mA	
Operating power supply current		SCK = 20 MHz		1.5	2.4	mA	
Standby current	lsв	$SCK = SI = \overline{CS} = V_{DD}$	_	5	15	μΑ	
Input high voltage	Vін	$V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$	$V_{\text{DD}} \times 0.8$	_	V _{DD} + 0.3	V	
Input low voltage	Vıl	$V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$	- 0.5	_	$V_{DD} \times 0.2$	V	
Output high voltage	Vон	Iон = −2 mA	V _{DD} - 0.5		V _{DD}	V	
Output low voltage	Vol	IoL = 2 mA	Vss		0.4	V	
Pull up resistance for $\overline{\text{CS}}$	RP	_	18	33	80	kΩ	

2. AC Characteristics

Downwater	Combal	Va	alue	Unit
Parameter	Symbol	Min	Max	Unit
SCK clock frequency	fcк	0	20	MHz
Clock high time	t cн	25	_	ns
Clock low time	t c∟	25	_	ns
Chip select set up time	t csu	10	_	ns
Chip select hold time	tсsн	10	_	ns
Output disable time	top	_	20	ns
Output data valid time	todv	_	18	ns
Output hold time	tон	0	_	ns
Deselect time	to	60	_	ns
Data rising time	t R	_	50	ns
Data falling time	tғ	_	50	ns
Data set up time	t su	5	_	ns
Data hold time	tн	5	_	ns
HOLD set up time	t HS	10	_	ns
HOLD hold time	tнн	10	_	ns
HOLD output floating time	tнz	_	20	ns
HOLD output active time	tız	_	20	ns

AC Test Condition

Power supply voltage : 2.7 V to 3.6 V

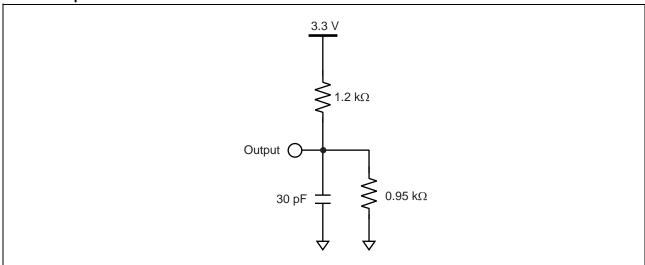
Operation ambient temperature : -40 °C to +85 °C

Input voltage magnitude $\,: 0.3 \ V$ to 2.7 V

Input rising time : 5 ns
Input falling time : 5 ns
Input judge level : VDD/2
Output judge level : VDD/2

MB85RS64

AC Load Equivalent Circuit

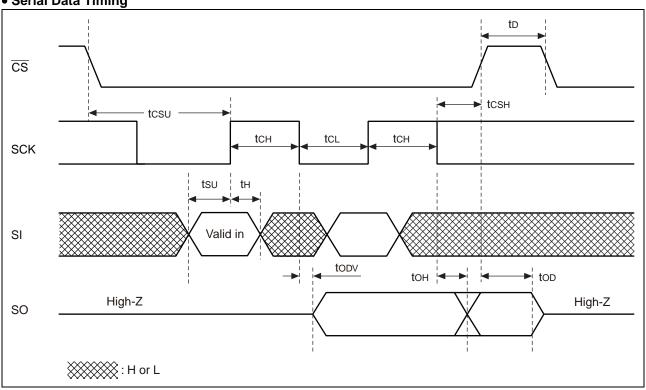


3. Pin Capacitance

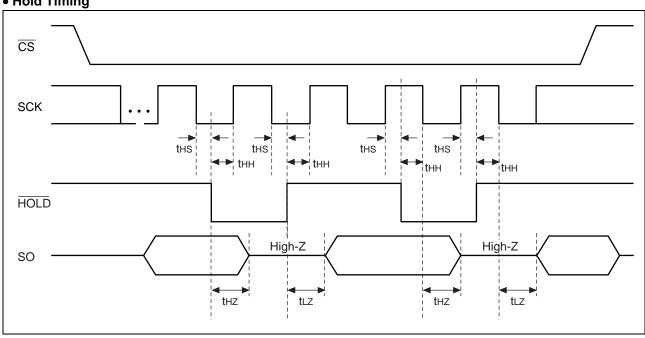
Parameter	Symbol	Conditions	Va	lue	Unit
Farameter	Зуппоп	Conditions	Min	Max	Onit
Output capacitance	Со	$V_{DD} = V_{IN} = V_{OUT} = 0 V$	_	10	pF
Input capacitance	Cı	$f = 1 \text{ MHz}, T_A = +25 ^{\circ}\text{C}$	_	10	pF

■ TIMING DIAGRAM

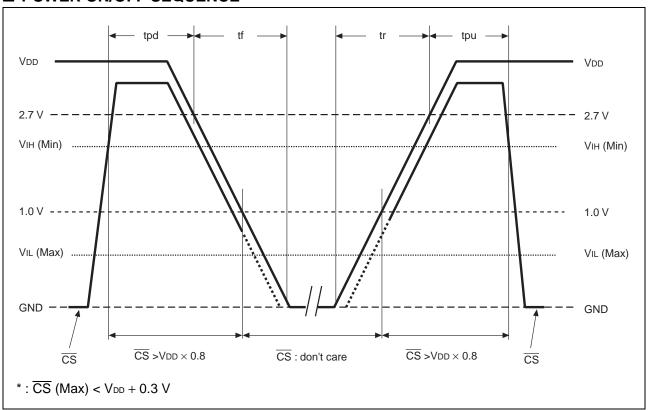
• Serial Data Timing



• Hold Timing



■ POWER ON/OFF SEQUENCE



Parameter	Symbol	Va	Unit	
Farameter	Symbol		Max	Offic
CS level hold time at power OFF	tpd	400	_	ns
CS level hold time at power ON	tpu	0.1	_	ms
Power supply falling time	tf	100	_	μs/V
Power supply rising time	tr	30	_	μs/V

If the device does not operate within the specified conditions of read cycle, write cycle or power on/off sequence, memory data can not be guaranteed.

■ FRAM CHARACTERISTICS

Item	Min	Max	Unit	Parameter
Read/Write Endurance*1	1012		Times/byte	Operation Ambient Temperature T _A = +85 °C
	10	_		Operation Ambient Temperature T _A = +85 °C
Data Retention*2	95	_	Years	Operation Ambient Temperature T _A = +55 °C
	≥ 200			Operation Ambient Temperature T _A = + 35 °C

^{*1:} Total number of reading and writing defines the minimum value of endurance, as an FRAM memory operates with destructive readout mechanism.

■ NOTE ON USE

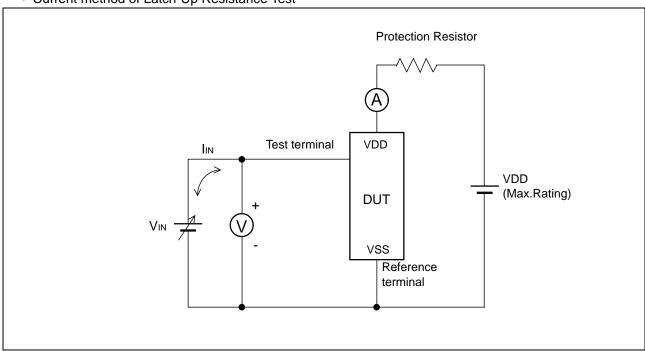
We recommend programming of the device after reflow. Data written before reflow cannot be guaranteed.

^{*2 :} Minimum values define retention time of the first reading/writing data right after shipment, and these values are calculated by qualification results.

■ ESD AND LATCH-UP

Test	DUT	Value
ESD HBM (Human Body Model) JESD22-A114 compliant		≥ 2000 V
ESD MM (Machine Model) JESD22-A115 compliant		≥ 200 V
ESD CDM (Charged Device Model) JESD22-C101 compliant		≥ 1000 V
Latch-Up (I-test) JESD78 compliant	MB85RS64PNF-G-JNE1	_
Latch-Up (V _{supply} overvoltage test) JESD78 compliant		_
Latch-Up (Current Method) Proprietary method		_
Latch-Up (C-V Method) Proprietary method		≥ 200 V

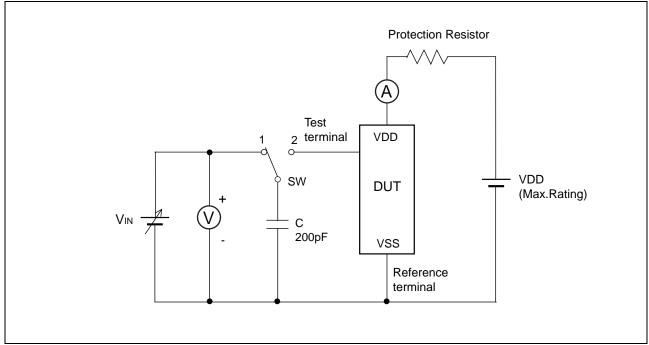
• Current method of Latch-Up Resistance Test



Note: The voltage V_{IN} is increased gradually and the current I_{IN} of 300 mA at maximum shall flow. Confirm the latch up does not occur under $I_{IN} = \pm 300$ mA.

In case the specific requirement is specified for I/O and I_{IN} cannot be 300 mA, the voltage shall be increased to the level that meets the specific requirement.

• C-V method of Latch-Up Resistance Test



Note: Charge voltage alternately switching 1 and 2 approximately 2 sec interval. This switching process is considered as one cycle.

Repeat this process 5 times. However, if the latch-up condition occurs before completing 5 times, this test must be stopped immediately.

■ REFLOW CONDITIONS AND FLOOR LIFE

[JEDEC MSL] : Moisture Sensitivity Level 3 (ISP/JEDEC J-STD-020D)

■ CURRENT STATUS ON CONTAINED RESTRICTED SUBSTANCES

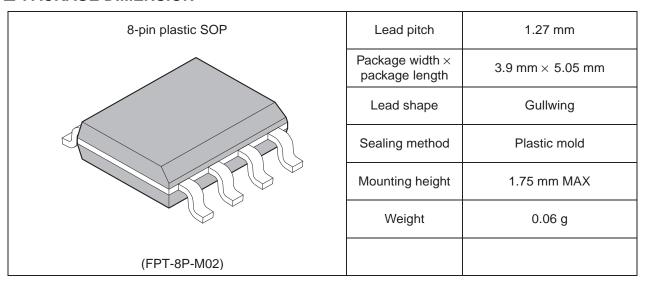
This product complies with the regulations of REACH Regulations, EU RoHS Directive and China RoHS.

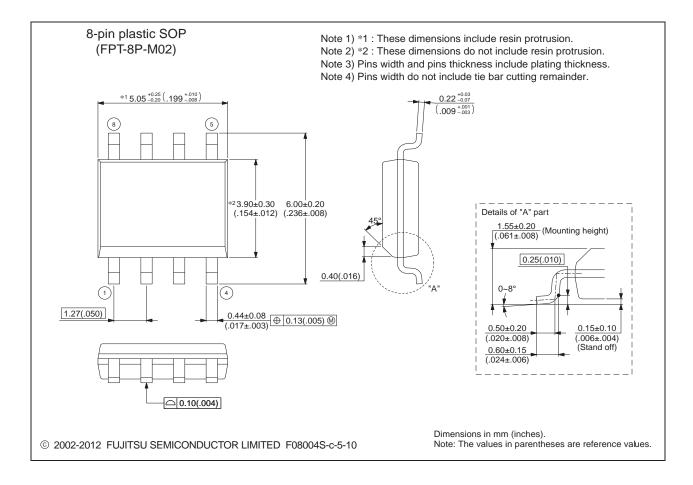
■ ORDERING INFORMATION

Part number	Package	Shipping form	Minimum shipping quantity
MB85RS64PNF-G-JNE1	8-pin plastic SOP (FPT-8P-M02)	Tube	*
MB85RS64PNF-G-JNERE1	8-pin plastic SOP (FPT-8P-M02)	Embossed Carrier tape	1500

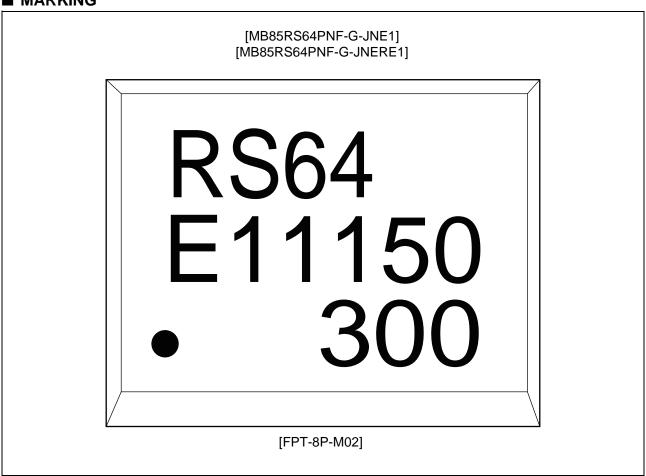
^{*:} Please contact our sales office about minimum shipping quantity.

■ PACKAGE DIMENSION





■ MARKING

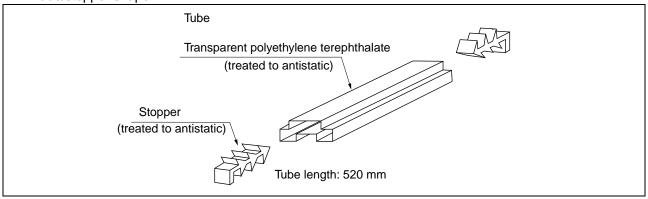


■ PACKING INFORMATION

1. Tube

1.1 Tube Dimensions

Tube/stopper shape

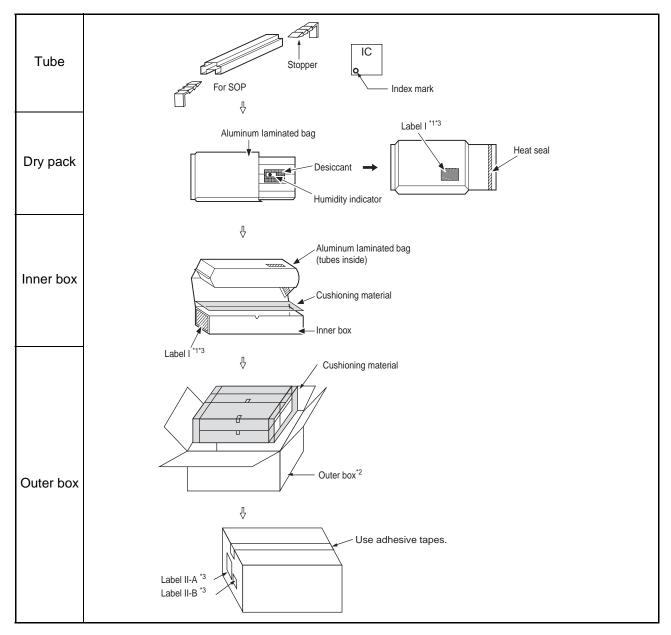


Tube cross-sections and Maximum quantity

		Maximum quantity			
Package form	Package code	pcs/ tube	pcs/inner box	pcs/outer box	
SOP, 8, plastic (2)	FPT-8P-M02	95	7600	30400	
7.4 6.4 					
©2006-2010 FUJITSU SEMICONDUCTOR LIMITED F08008-SET1-PET:FJ99L-0022-E0008-1-K-3					
t = 0.5 Transparent polyethylene terephthalate					

(Dimensions in mm)

1.2 Tube Dry pack packing specifications



^{*1:} For a product of witch part number is suffixed with "E1", a " [G] (N)" marks is display to the moisture barrier bag and the inner boxes.

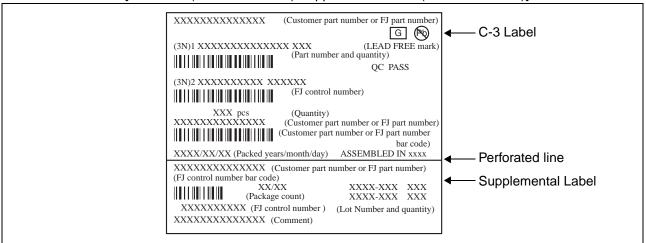
Note: The packing specifications may not be applied when the product is delivered via a distributor.

^{*2:} The space in the outer box will be filled with empty inner boxes, or cushions, etc.

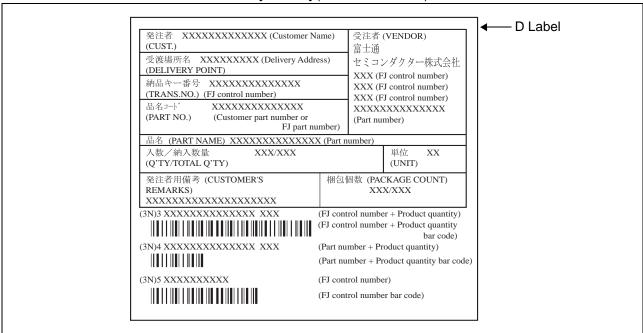
^{*3:} Please refer to an attached sheet about the indication label.

1.3 Product label indicators

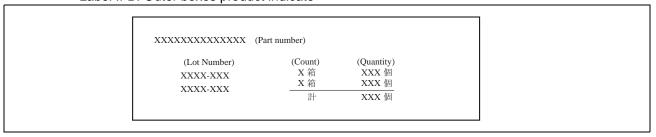
Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping) [C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



Label II-A: Label on Outer box [D Label] (100mm × 100mm)



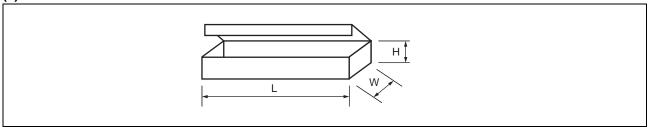
Label II-B: Outer boxes product indicate



Note: Depending on shipment state, "Label II-A" and "Label II-B" on the external boxes might not be printed.

1.4 Dimensions for Containers

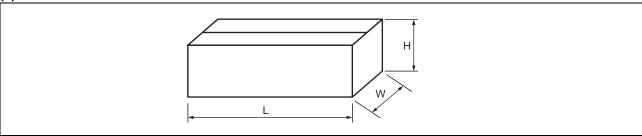
(1) Dimensions for inner box



L	W	Н
540	125	75

(Dimensions in mm)

(2) Dimensions for outer box



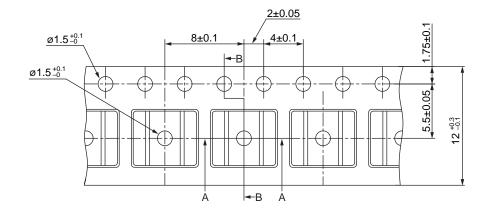
L	W	Н
565	270	180

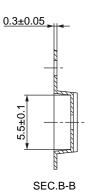
(Dimensions in mm)

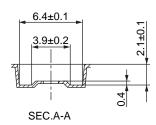
2. Emboss Tape

2.1 Tape Dimensions

PKG code	de Reel No		Maximum storage capacity			
1 110 0000	11001110	pcs/reel	pcs/inner box	pcs/outer box		
FPT-8P-M02	3	1500	1500	10500		







© 2012 FUJITSU SEMICONDUCTOR LIMITED SOL8-EMBOSSTAPE9: NFME-EMB-X0084-1-P-1

(Dimensions in mm)

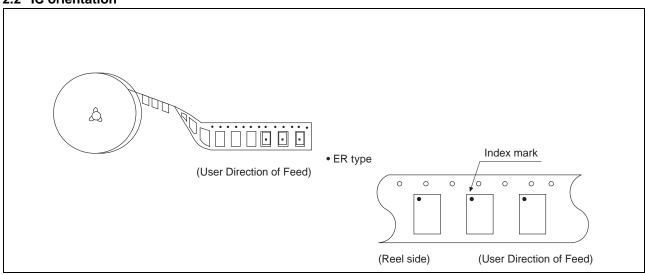
Material: Conductive polystyrene

Heat proof temperature : No heat resistance.

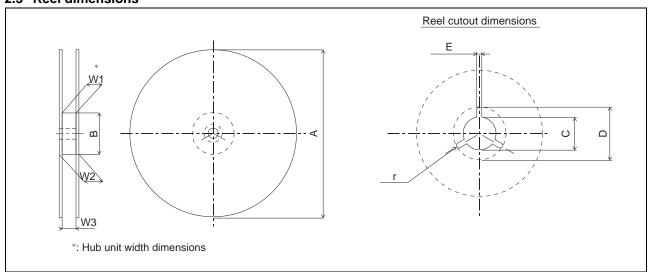
Package should not be baked

by using tape and reel.

2.2 IC orientation



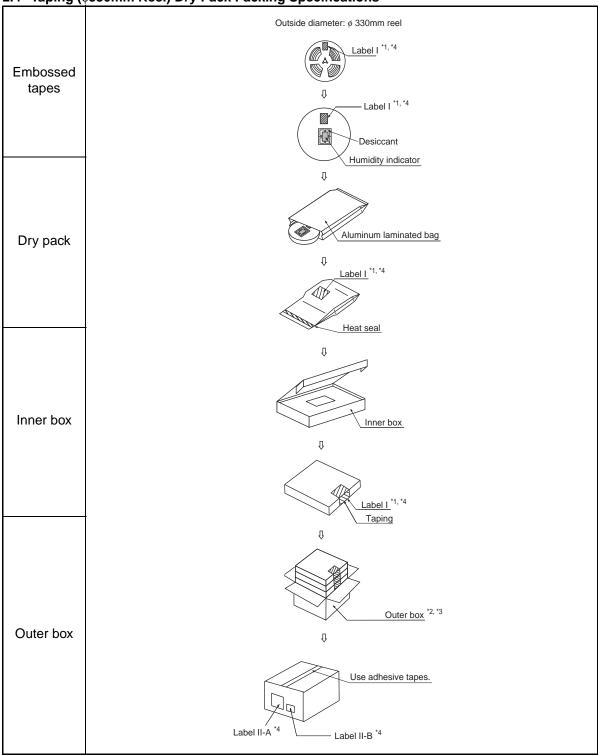
2.3 Reel dimensions



Dimensions in mm

														imensioi	
Reel No	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
Tape width Symbol	8	1	2	1	6	2	4	3.	2	4	4	56	12	16	24
Α	254 ± 2	254 ± 2	330 ± 2	254 ± 2	330 ± 2	254 ± 2	330 ± 2				330) ± 2			
В				1	00 +2			100 -0	150 ⁺² ₋₀	100 +2	150 +2	100 -0	100 ± 2		
С		13 ± 0.2 $13^{+0.5}_{-0.2}$													
D	21 ± 0.8								20.5 +1 -0.2						
E								2 ± 0.5							
W1	8.4 ⁺² 12.4 ⁺² 16.4 ⁺² 24.4 ⁺² 32.4 ⁺² 44.4 ⁺² 56.4 ⁺²						56.4 +2	12.4 +1	16.4 +1	24.4 ^{+0.1}					
W2	less than 14.4 less than 18.4 less than 22.4 less than 30.4 less than 38.4 less than 50.4 less than 62.4							less than 18.4	less than 22.4	less than 30.4					
W3	7.9 ~ 10.9	11.9 -	~ 15.4	15.9	~ 19.4	23.9 -	- 27.4	31.9 ~ 35.4 43.9 ~ 47.4 55.9 ~ 59.4			12.4 ~ 14.4	16.4 ~ 18.4	24.4 ~ 26.4		
r		1.0													

2.4 Taping (\(\psi 330mm \) Reel) Dry Pack Packing Specifications



Note: The packing specifications may not be applied when the product is delivered via a distributor.

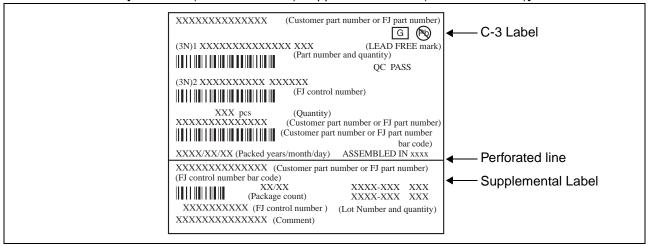
^{*2:} The size of the outer box may be changed depending on the quantity of inner boxes.

^{*3:} The space in the outer box will be filled with empty inner boxes, or cushions, etc.

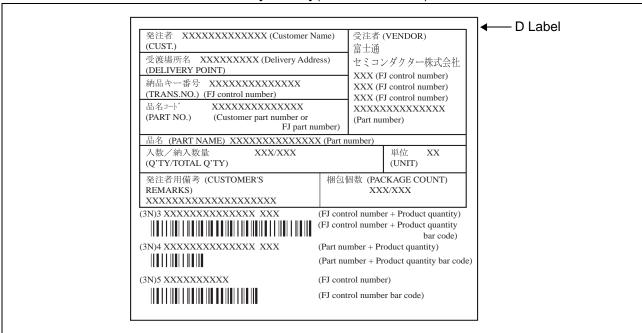
^{*4:} Please refer to an attached sheet about the indication label.

2.5 Product label indicators

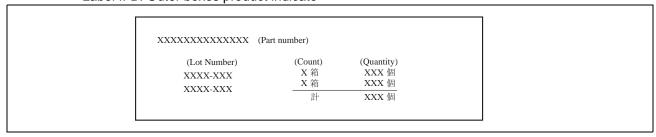
Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping) [C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



Label II-A: Label on Outer box [D Label] (100mm × 100mm)



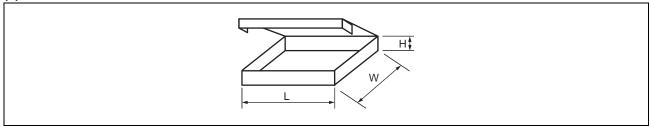
Label II-B: Outer boxes product indicate



Note: Depending on shipment state, "Label II-A" and "Label II-B" on the external boxes might not be printed.

2.6 Dimensions for Containers

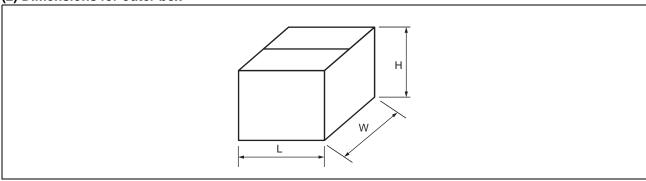
(1) Dimensions for inner box



Tape width	L	W	Н
12, 16		345	40
24, 32	365		50
44	365	343	65
56			75

(Dimensions in mm)

(2) Dimensions for outer box



L	W	Н
415	400	315

(Dimensions in mm)

■ MAJOR CHANGES IN THIS EDITION

A change on a page is indicated by a vertical line drawn on the left side of that page.

Page	Section	Change Results
11	■ RECOMMENDED OPERATING CONDITIONS	Added note on the Operation Ambient Temperature. Moved the "High Level Input Voltage" and "Low Level Input Voltage" to DC Characteristics.
	1. DC Characteristics	Added Operating power supply current (typ) of lower frequency.
12		Moved the "High Level Input Voltage" and "Low Level Input Voltage" from RECOMMENDED OPERATING CONDITIONS.
18	■ CURRENT STATUS ON CON- TAINED RESTRICTED SUBSTANC- ES	Deleted the URL info.
20	■ PACKAGE DIMENSION	Deleted the URL info.

FUJITSU SEMICONDUCTOR LIMITED

Shin-Yokohama Chuo Building, 2-100-45 Shin-Yokohama, Kohoku-ku, Yokohama, Kanagawa 222-0033, Japan http://ip.fujitsu.com/fsl/en/

All Rights Reserved.

FUJITSU SEMICONDUCTOR LIMITED, its subsidiaries and affiliates (collectively, "FUJITSU SEMICONDUCTOR") reserves the right to make changes to the information contained in this document without notice. Please contact your FUJITSU SEMICONDUCTOR sales representatives before order of FUJITSU SEMICONDUCTOR device.

Information contained in this document, such as descriptions of function and application circuit examples is presented solely for reference to examples of operations and uses of FUJITSU SEMICONDUCTOR device. FUJITSU SEMICONDUCTOR disclaims any and all warranties of any kind, whether express or implied, related to such information, including, without limitation, quality, accuracy, performance, proper operation of the device or non-infringement. If you develop equipment or product incorporating the FUJITSU SEMICONDUCTOR device based on such information, you must assume any responsibility or liability arising out of or in connection with such information or any use thereof. FUJITSU SEMICONDUCTOR assumes no responsibility or liability for any damages whatsoever arising out of or in connection with such information or any use thereof.

Nothing contained in this document shall be construed as granting or conferring any right under any patents, copyrights, or any other intellectual property rights of FUJITSU SEMICONDUCTOR or any third party by license or otherwise, express or implied. FUJITSU SEMICONDUCTOR assumes no responsibility or liability for any infringement of any intellectual property rights or other rights of third parties resulting from or in connection with the information contained herein or use thereof.

The products described in this document are designed, developed and manufactured as contemplated for general use including without limitation, ordinary industrial use, general office use, personal use, and household use, but are not designed, developed and manufactured as contemplated (1) for use accompanying fatal risks or dangers that, unless extremely high levels of safety is secured, could lead directly to death, personal injury, severe physical damage or other loss (including, without limitation, use in nuclear facility, aircraft flight control system, air traffic control system, mass transport control system, medical life support system and military application), or (2) for use requiring extremely high level of reliability (including, without limitation, submersible repeater and artificial satellite). FUJITSU SEMICONDUCTOR shall not be liable for you and/or any third party for any claims or damages arising out of or in connection with above-mentioned uses of the products.

Any semiconductor devices fail or malfunction with some probability. You are responsible for providing adequate designs and safeguards against injury, damage or loss from such failures or malfunctions, by incorporating safety design measures into your facility, equipments and products such as redundancy, fire protection, and prevention of overcurrent levels and other abnormal operating conditions.

The products and technical information described in this document are subject to the Foreign Exchange and Foreign Trade Control Law of Japan, and may be subject to export or import laws or regulations in U.S. or other countries. You are responsible for ensuring compliance with such laws and regulations relating to export or re-export of the products and technical information described herein. All company names, brand names and trademarks herein are property of their respective owners.

Edited: System Memory Business Division

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for F-RAM category:

Click to view products by Fujitsu manufacturer:

Other Similar products are found below:

FM22LD16-55-BG FM25CL64B-DGTR CY15B104Q-PZXI CY15B128Q-SXE CY15B256Q-SXAT MB85RC64APNF-G-JNE1

MB85RS128BPNF-G-JNE1 MB85R4002ANC-GE1 FM25640B-G FM25640B-GTR FM25V02A-DGQ FM24V05-GTR CY15B104Q
LHXIT CY15B104Q-SXIT FM24V01A-GTR FM24V02A-GTR FM24W256-GTR FM25V02A-DGTR FM28V020-SGTR FM28V202A-TG

CY15B104Q-LHXI CY15V108QN-20LPXI CY15V108QN-40LPXI CY15B104QSN-108LPXI CY15B104QSN-108SXI CY15B104Q-SXI

CY15V104QI-20LPXC CY15B108QI-20LPXC CY15B108QI-20LPXI CY15B108QN-40SXI CY15V104QSN-108LPXI CY15V104QSN
108SXI CY15B108QN-40LPXI CY15V108QI-20LPXC CY15V108QN-20LPXC FM16W08-SG FM1808B-SG FM18W08-SG FM22L16
55-TG FM24C04B-G FM24C04B-GTR FM24C16B-GTR FM24C64B-G FM24CL04B-G FM24CL04B-GTR FM24CL16B-DG

FM24CL16B-GTR FM24CL64B-G FM24CL64B-GTR FM24V05-G